

PTO-1449 Information Disclosure Citation in an Application			Application No.	Applicant(s): Hans Norström et al.			
			Docket Number 068758.0182	Group Art Unit	Filing Date April 21, 2004		
U.S. PATENT DOCUMENTS							
		DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
<input checked="" type="checkbox"/>	1	5,587,327	12-24-96	König et al.	437	31	05-23-95
<input checked="" type="checkbox"/>	2	5,821,149	10-13-98	Schüppen et al.	438	312	03-14-97
<input checked="" type="checkbox"/>	3	6,251,738	06-26-01	Huang	438	312	01-10-00
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<input checked="" type="checkbox"/>	4	DE 196 52 423 A1	06-10-98	GERMANY	H01L	29/737	x
<input checked="" type="checkbox"/>	5	SE 0101567-6	12-23-02	SWEDEN	H01L	21/8249	x
<input checked="" type="checkbox"/>	6	EP 1 139 408 A2	01-26-01	EPO	H01L	21/331	x
<input checked="" type="checkbox"/>	7	WO 98/53489	11-26-98	PCT	H01L	21/331	x
<input checked="" type="checkbox"/>	8	WO 01/20664	03-22-01	PCT	H01L	21/76	x
NON-PATENT DOCUMENTS							
		DOCUMENT (Including Author, Title, Source, and Pertinent Pages)				DATE	
<input checked="" type="checkbox"/>	9	A Schüppen et al., "Enhanced SiGe Heterojunction Bipolar Transistors with 160 GHz-f _{max} "; IEEE IEDM Tech Dig., p. 743				1995	
<input checked="" type="checkbox"/>	10	A. Monroy et al., "BiCMOS6G: A high performance .035 μm SiGe BiCMOS technology for wireless applications", IEEE BCTM, p. 121				1999	
<input checked="" type="checkbox"/>	11	S.A. St.Onge et al., "A 0.24 μm SiGe BiCMOS Mixed-Signal RF Production Technology Featuring a 47 GHz f _t HBT and 0.18 μm L _{eff} CMOS"; IEEE BCTM99, p. 117				1999	
<input checked="" type="checkbox"/>	12	John D. Cressler, "SiGe HBT Technology: A New Contender for Si-Baesd RF and Microwave Circuit Applications"; IEEE Transactions on Microwave Theory and Techniques, Vol. 46, No. 5				May 1998	
<input checked="" type="checkbox"/>	13	D. Behammer, et al.; "Si/SiGe HBTs for Application in Low Power ICs"; Solid-State Electronics, Vol. 39, No. 4, pp. 471-480				1996	
EXAMINER <i>A. Jay Tassi</i>			DATE CONSIDERED <i>8/26/05</i>				
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.							